

# UNISONIC TECHNOLOGIES CO.,LTD.

XL/ML1225 scr

# MEDIUM POWER LOW VOLTAGE TRANSISTOR

#### ■ DESCRIPTION

The XL1225/ML1225 silicon controlled rectifiers are high performance planner diffused PNPN devices. These parts are intended for low cost high volume applications.



\*Pb-free plating product number: XL1225L/ML1225L

#### **■ PIN CONFIGURATION**

PIN NO.	PIN NAME	
1	CATHODE	
2	GATE	
3	ANODE	

#### ■ ORDERING INFORMATION

Order Number			Package	Packing	
Norma		Lead free	rackage	Facking	
XL1225-T	92-B	XL1225L-T92-B	TO-92	Tape Box	
XL1225-T	92-K	XL1225L-T92-K	TO-92	Bulk	
ML1225-T	92-B	ML1225L-T92-B	TO-92	Tape Box	
ML1225-T	92-K	ML1225L-T92-K	TO-92	Bulk	

XL/ML1225 scr

# ■ ABSOLUATE MAXIUM RATINGS (Ta= 25 , unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITION	RATINGS	UNIT
Repetitive Peak	XL1225	\/	T <sub>J</sub> =40 ~ 125°C	400	٧
Off-State Voltage	ML1225	$V_{DRM}$	$R_{GK} = 1k\Omega$	300	V
On-State Current		I <sub>T(RMS)</sub>	Tc=40°C	0.8	Α
Average On-State Current		I <sub>T(AV)</sub>	Half Cycle=180,Tc=40°C	0.5	Α
Peak Reverse Gate Voltage		$V_{GRM}$	IGR=10uA	1	V
Peak Gate Current		I <sub>GM</sub>	10us Max.	0.1	Α
Gate Dissipation		P <sub>G(AV)</sub>	20ms Max.	150	mW
Operating Temperature		$T_J$	_	+125	°C
Storage Temperature		T <sub>STG</sub>		-40 ~ +150	°C

Note 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

# ■ **ELECTRICAL CHARACTERISTICS** (Ta= 25 , unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Off State Leakage Current	I <sub>DRM</sub>	$@V_{DRM}(R_{GK}=1K\Omega), T_J=125^{\circ}C$			0.1	mA	
Off State Leakage Current	I <sub>DRM</sub>	$@V_{DRM}(R_{GK}=1K\Omega), T_J=25^{\circ}C$			1.0	μΑ	
On State Voltage	$V_{T}$	AT I <sub>T</sub> =0.4A			1.4	1.4 V	
on state vertage	٧١	AT I <sub>T</sub> =0.8A			2.2	V	
On State Threshold Voltage	$V_{T(TO)}$	T <sub>J</sub> =125°C			0.95	V	
On State Slops Resistance	Rt	T <sub>J</sub> =125°C			600	m	
Gate Trigger Current	$I_{GT}$	V <sub>D</sub> =7V			200	μΑ	
Gate Trigger Voltage	$V_{GT}$	V <sub>D</sub> =7V			0.8	V	
Holding Current	I <sub>H</sub>	$R_{GK}=1K\Omega$			5	mA	
Latching Current	IL	$R_{GK}=1K\Omega$			6	mA	
Critical Rate of Voltage Rise	DV/DT	$V_D = 0.67^* V_{DRM} (R_{GK} = 1 K\Omega), T_J = 125$				V/μs	
Critical Rate of Current Rise	DV/DT	$I_{G}=10\text{mA}, dI_{G}/dt=0.1\text{A}/\mu\text{s}, T_{J}=125$				A/μs	
Gate Controlled Delay Time	T <sub>GD</sub>	l <sub>G</sub> =10mA, dl <sub>G</sub> /dt=0.1A/μs			2.2	μS	
Commutated Turn-off Time	TG	$T_J = 85^{\circ}C, V_D = 0.67^*V_{DRM}$ $V_R = 35V, I_T = I_{T(AV)}$			200	μs	

# ■ CLASSIFICATION OF I<sub>GT</sub>

RANK	В	С	AA	AB	AC	AD
RANGE	50-100սA	100-200uA	8-15uA	15-20uA	20-25uA	25-50uA

<sup>2.</sup> The device is guaranteed to meet performance specification within 0  $\sim$ 70 operating temperature range and assured by design from  $-20 \sim 85$ .

XL/ML1225 scr

# **TYPICAL CHARACTERICS**

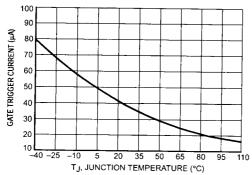
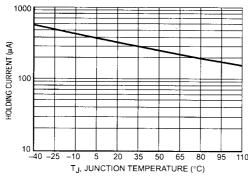


Figure 1. Typical Gate Trigger Current versus Junction Temperature

Figure 2. Typical Gate Trigger Voltage versus Junction Temperature



1000 (P) 100 (

Figure 3. Typical Holding Current versus Junction Temperature

Figure 4. Typical Latching Current versus Junction Temperature

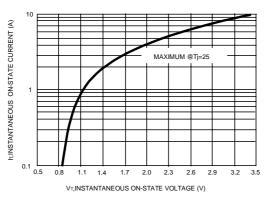


Figure 5. Typical On-State Characteristics

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.